

**Search Notes**

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Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

TANAKA, TOSHIYUKI

Art Unit

2615

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED EAST SEARCH (USPAT, PGPUB, JPO, EPO, DERWENT)	7/25/2005	NT